

**Search Notes**

Application/Control No.

10/601,655

Examiner

Madeleine AV Nguyen

Applicant(s)/Patent under  
Reexamination

NAKAHARA, SHIGEKI

Art Unit

2626

**SEARCHED**

Class	Subclass	Date	Examiner
358	1.15	10/3/2005	AV
	442		
	444		
	404		
	405		
358	440	10/3/2005	AV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	4/5/2005	AV